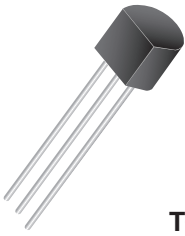
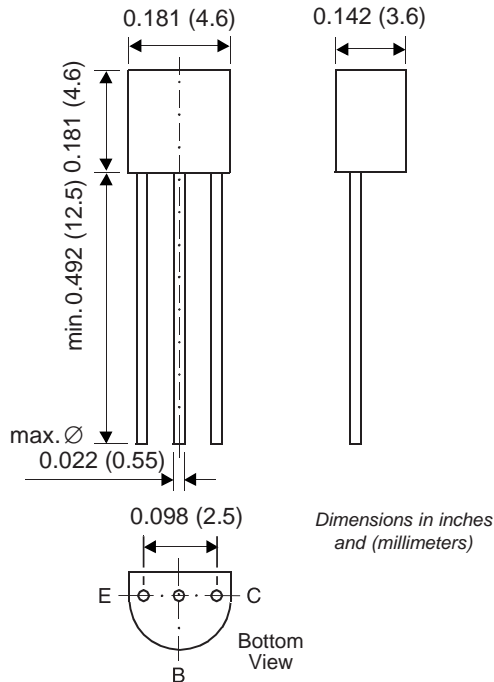


## Small Signal Transistor (PNP)


**TO-226AA (TO-92)**


### Features

- PNP Silicon Epitaxial Planar Transistor for switching and amplifier applications.
- On special request, this transistor is also manufactured in the pin configuration TO-18.
- This transistor is also available in the SOT-23 case with the type designation MMBT2907A.

### Mechanical Data

**Case:** TO-92 Plastic Package

**Weight:** approx. 0.18g

**Packaging Codes/Options:**

E6/Bulk – 5K per container, 20K/box

E7/4K per Ammo mag., 20K/box

### Maximum Ratings & Thermal Characteristics Ratings at 25°C ambient temperature unless otherwise specified.

Parameter	Symbol	Value	Unit
Collector-Base Voltage	$-V_{CBO}$	60	V
Collector-Emitter Voltage	$-V_{CEO}$	60	V
Emitter-Base Voltage	$-V_{EBO}$	5.0	V
Collector Current	$-I_C$	600	mA
Power Dissipation	$T_A = 25^\circ\text{C}$ Derate above 25°C	$P_{tot}$	625
			5.0
Power Dissipation	$T_C = 25^\circ\text{C}$ Derate above 25°C	$P_{tot}$	1.5
			12
Thermal Resistance Junction to Ambient Air	$R_{\theta JA}$	200 <sup>(1)</sup>	°C/W
Thermal Resistance Junction to Case	$R_{\theta JC}$	83.3	°C/W
Junction Temperature	$T_j$	150	°C
Storage Temperature Range	$T_S$	-55 to +150	°C

**Note:**

(1) Valid provided that leads are kept at ambient temperature.

**Electrical Characteristics** (T<sub>J</sub> = 25°C unless otherwise noted)

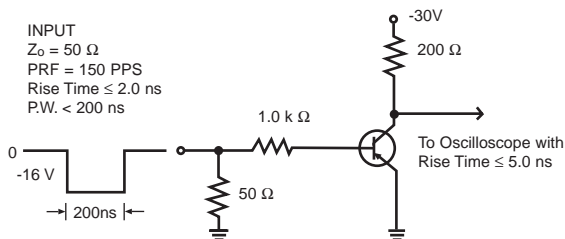
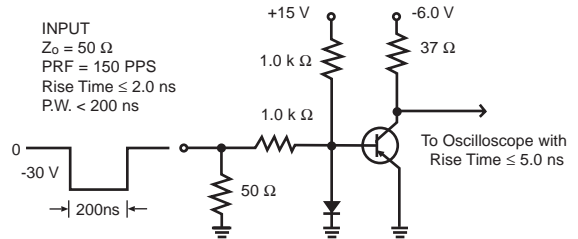
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
DC Current Gain	h <sub>FE</sub>	-V <sub>CE</sub> = 10V, -I <sub>C</sub> = 0.1mA	75	—	—	—
		-V <sub>CE</sub> = 10V, -I <sub>C</sub> = 1mA	100	—	—	—
		-V <sub>CE</sub> = 10V, -I <sub>C</sub> = 10mA	100	—	—	—
		-V <sub>CE</sub> = 10V, -I <sub>C</sub> = 150mA <sup>(1)</sup>	100	300	—	—
		-V <sub>CE</sub> = 10V, -I <sub>C</sub> = 500mA <sup>(1)</sup>	50	—	—	—
Collector-Base Breakdown Voltage	-V <sub>(BR)CBO</sub>	-I <sub>C</sub> = 10μA, I <sub>E</sub> = 0	60	—	—	V
Collector-Emitter Breakdown Voltage <sup>(1)</sup>	-V <sub>(BR)CEO</sub>	-I <sub>C</sub> = 10mA, I <sub>B</sub> = 0	60	—	—	V
Emitter-Base Breakdown Voltage	-V <sub>(BR)EBO</sub>	-I <sub>E</sub> = 10μA, I <sub>C</sub> = 0	5	—	—	V
Collector-Emitter Saturation Voltage <sup>(1)</sup>	-V <sub>CEsat</sub>	-I <sub>C</sub> = 150mA, -I <sub>B</sub> = 15mA	—	—	0.4	V
		-I <sub>C</sub> = 500mA, -I <sub>B</sub> = 50mA	—	—	1.6	V
Base-Emitter Saturation Voltage <sup>(1)</sup>	-V <sub>BEsat</sub>	-I <sub>C</sub> = 150mA, -I <sub>B</sub> = 15mA	—	—	1.3	V
		-I <sub>C</sub> = 500mA, -I <sub>B</sub> = 50mA	—	—	2.6	V
Collector Cut-off Current	-I <sub>CEV</sub>	-V <sub>EB</sub> = 0.5V, -V <sub>CE</sub> = 30V	—	—	50	nA
Collector Cut-off Current	-I <sub>CBO</sub>	-V <sub>CB</sub> = 50V, I <sub>E</sub> = 0	—	—	0.01	μA
		-V <sub>CB</sub> = 50V, I <sub>E</sub> = 0, T <sub>A</sub> = 150°C	—	—	10	μA
Base Cut-off Current	-I <sub>BL</sub>	-V <sub>EB</sub> = 0.5V, -V <sub>CE</sub> = 30V	—	—	50	nA
Current Gain-Bandwidth Product	f <sub>T</sub>	-V <sub>CE</sub> = 20V, -I <sub>C</sub> = 50mA f = 100MHz	200	—	—	MHz
Output Capacitance	C <sub>obo</sub>	-V <sub>CB</sub> = 10V, f = 1MHz, I <sub>E</sub> = 0	—	—	8.0	pF
Emitter-Base Capacitance	C <sub>ibo</sub>	-V <sub>EB</sub> = 2.0V, f = 1MHz, I <sub>C</sub> = 0	—	—	30	pF

**Notes:**

(1) Pulse Test: Pulse width ≤ 300 μs, duty cycle ≤ 2.0%

**Electrical Characteristics** ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Turn-ON Time	$t_{on}$	$-I_{B1} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 30\text{V}$	—	—	45	ns
Delay Time (see fig. 1)	$t_d$	$-I_{B1} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 30\text{V}$	—	—	10	ns
Rise Time (see fig. 1)	$t_r$	$-I_{B1} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 30\text{V}$	—	—	40	ns
Turn-OFF Time	$t_{off}$	$-I_{B1} = -I_{B2} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 6\text{V}$	—	—	100	ns
Storage Time (see fig. 2)	$t_s$	$-I_{B1} = -I_{B2} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 6\text{V}$	—	—	80	ns
Fall Time (see fig. 2)	$t_f$	$-I_{B1} = -I_{B2} = 15\text{mA}$ , $-I_C = 150\text{mA}$ , $-V_{CC} = 6\text{V}$	—	—	30	ns

**Switching Time Equivalent Test Circuit**
**Figure 1: Delay and Rise Time test circuit**

**Figure 2: Storage and Fall Time test circuit**




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